

**Search Notes**

Application/Control No.

10/790,633

Examiner

Steven S. Paik

Applicant(s)/Patent under  
Reexamination

WASHINGTON ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	379		
	380		
271	145	3/3/2006	SSP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		
Text search	3/3/2006	SSP